#### **FORM PTO-1449**

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

ATTY. DOCKET NO.	SERIAL NO.		
576P079	10/550,648		
Takafumi Fujii et al.			

Not yet assigned 1793

#### **REFERENCE DESIGNATION**

# **U.S. PATENT DOCUMENTS**

September 27, 2005

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/HK/	AA	2004/0045478	11/2004	Keiichi Tateishi **	106	31.49	
	AB				<b>†</b>	<u> </u>	
	AC					1	

#### **FOREIGN PATENT DOCUMENTS**

		DOCUMENT					TRANS	LATION
	]	NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
/HK/	BA	0 418 792	3/1991	*Europe			X-SR	
/HK/	BB	3-185080	8/1991	Japan				X-SR
/HK/	BC	02/060994	8/2002	WO**				X-SR
	BD					· · · · · · · · · · · · · · · · · · ·		<u> </u>

# OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

/HK/	CA	Сору	of the International Search Rep	oort dated 5/18/04
	CB			•
	CC			
	CD			
EXAMINE	R /H	elene Klemanski/	DATE CONSIDERED	01/06/2008
				conformance with MPEP 609;

SR=Cited in Search Report

next communication to applicant.

<sup>\*=</sup>Corresponding EP patent (in English)

<sup>\*\*=</sup>Corresponding US patent application

# FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT AUG 9 1001 FILING DATE September 27, 2005 SERIAL NO. 576P079 Takafumi Fujii et al. FILING DATE September 27, 2005 1755 1793

REFERENCE DESCRIPTION

## **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/HK/	AA	3,622,263	11/1971	Groll et al.	8	178	
/HK/	AB	5,847,111	12/1998	Wald et al.	540	125	

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		DOCUMENT					TRANS	LATION
_:	1	NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
/HK/	BA	0 669 381	8/1995	Europe				1
<u> </u>	BB	0 906 943	4/1999	Europe				<u> </u>
	BC	0 985 716	3/2000	Europe	_			<del>                                     </del>
	BD	728931	12/1942	Germany				X-SR
	BE	195 21 056	12/1995	Germany	·			**XSR
	BF	2 290 548	1/1996	Great Britain **				1
	BG	57-198758	12/1982	Japan				
V	ВН	60-208365	10/1985	Japan			•	<del>                                     </del>
/HK/	BI	61-2772	1/1986	Japan			•	

### OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

/HK/	CA	H.R. Schweizer: May 19, 1964; XP002435570 page 510-511.
/HK/	СВ	Copy of the Supplemental European Search Report dated 5/30/07.
	CC	
	CD	
	CE	

**EXAMINER** 

/Helene Klemanski/

DATE CONSIDERED

01/06/2008

EXAMINER: Initial reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

SR=Cited in Search Report

<sup>\*=</sup>English Abstract

<sup>\*\*=</sup>Corresponding English reference

•	319			
FORM PTO-1449	AUG 3 1 2007	<b>ATTY. DOCKET NO.</b> 576P079	<b>SERIAL NO.</b> 10/550,648	
LIST OF PATENTS A APPLICANT'S INFO STATEMENT	AND PUBLICATIONS FOR RMATION DISCLOSURE	Takafumi Fujii et al.		<u>,                                     </u>
	•	FILING DATE	GROUP	
		September 27, 2005	175E 1793	

#### REFERENCE DESIGNATION

# **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF
/HK/	AA	5,922,116	7/1999	Mistry et al.	106	31.47	
/HK/	AB	7,034,149	4/2006	Hirokazu et al.	540	145	<del></del>
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		DOCUMENT					TRANS	LATION
		NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
/HK/	BA	59-22967	2/1984	Japan			*	
	BB	62-190273	8/1987	Japan	<u> </u>		•	<del></del>
	BC	5-171085	7/1993	Japan	_		•	-
	BD	7-138511	5/1995	Japan			•	
	BE	10-140063	5/1998	Japan			*	
	BF	11-515048	12/1999	Japan			**	-
	BG	2000-303009	10/2000	Japan			*	
1/	ВН	2002-80762	3/2002	Japan		_	•	
V	BI	2002-105349	4/2002	Japan			**	
/HK/	BJ	2003-34758	2/2003	Japan			•	

# OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

CA	
СВ	
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CD	
<b>EXAMINER</b> /Helene Klemanski/	DATE CONSIDERED 01/06/2008

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